



ACAT 2013

DATA ANALYSIS OF TRACKS OF HEAVY- ION PARTICLES IN TIMEPIX DETECTORS

Presenter:

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OUTLINE

Introduction

- Timepix devices
- Dose-Equivalent calculation

Angle calculation

- Azimuthal angle
- Polar angle

Volcano effect

Interactions

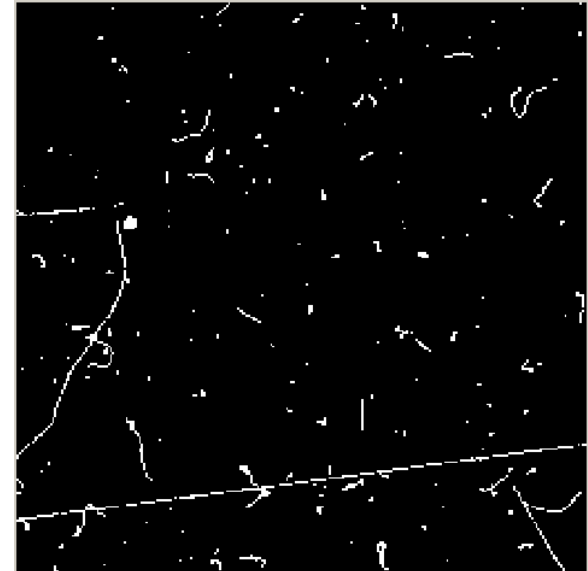
Experimental results

Future works

INTRODUCTION

Develop a Space Radiation Dosimeter

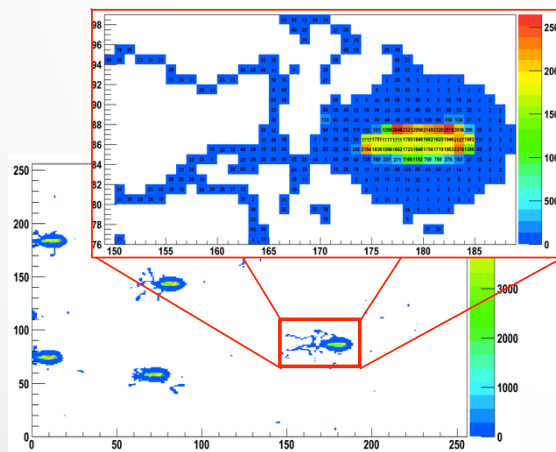
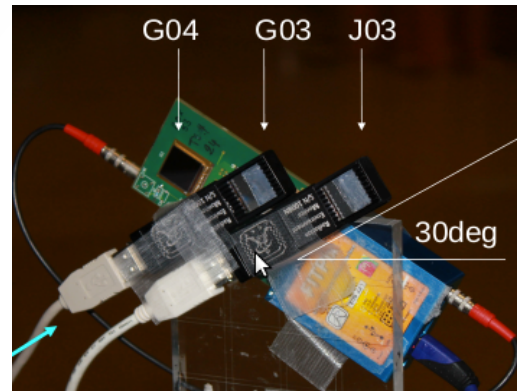
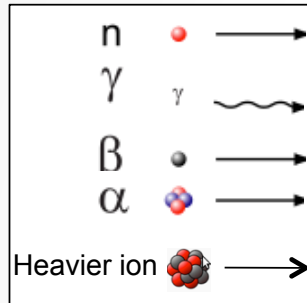
- Estimate LET
- Compute Dose, Dose-Equivalent



Characterize ionizing radiation in space

- Detect and visualize primary and secondary radiation
- Identify a source of a heavy ion particle
- Measure energy

INTRODUCTION



Pattern
recognition



Dose ?

LET ?

Dose-equivalent ?

Energy ?

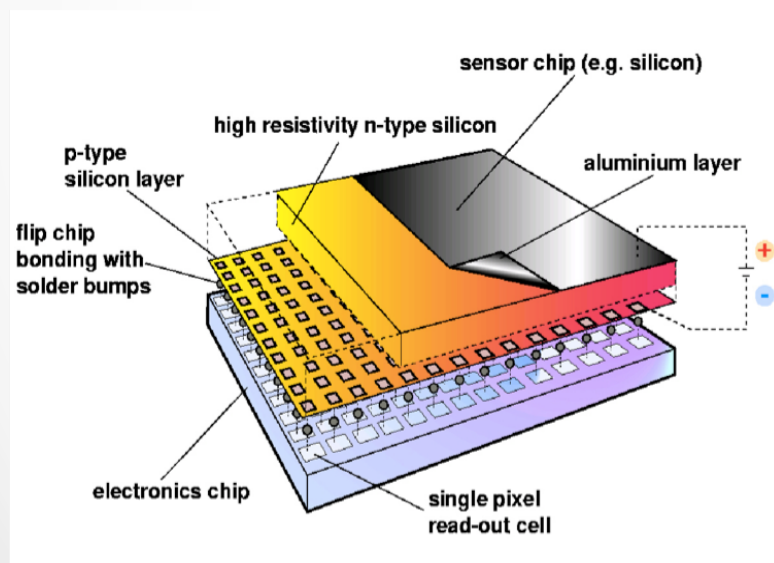
Type of Ion ?



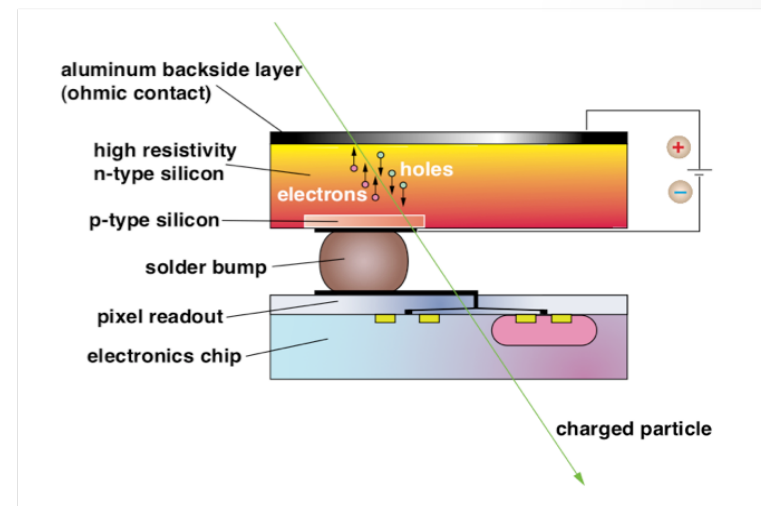
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TIMEPIX DEVICE

- Hybrid semiconductor CMOS-based pixel detector
- Overlying Si sensor layer attached
- 256 x 256 square pixels
- 55 μm square pixel



Timepix configuration

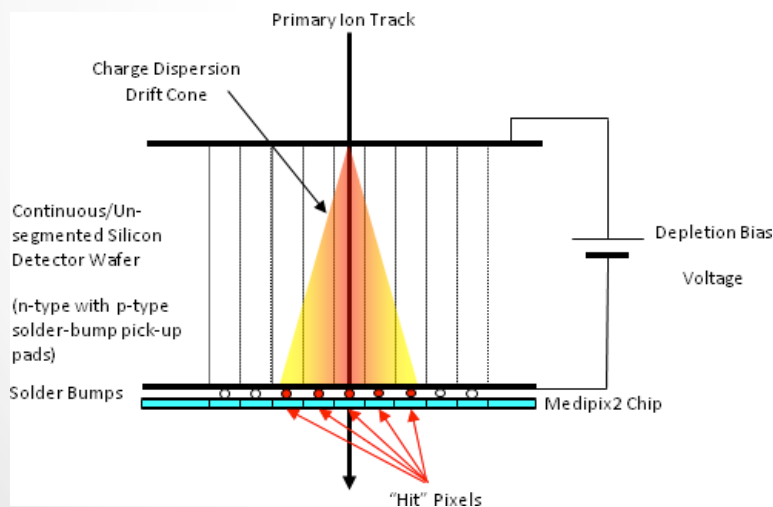


Pixel circuitry

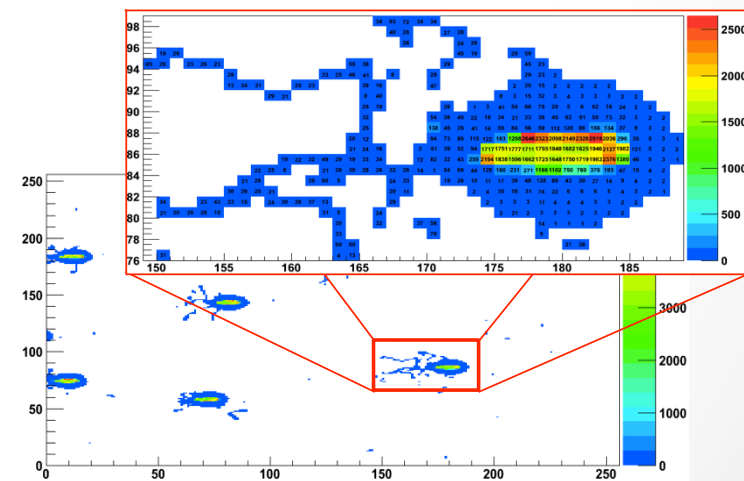


TIMEPIX DEVICE

- A charged particle ionizes atoms along its path
- A core of charge carriers is produced
- Charges drift along and diffuse perpendicular to an applied bias-voltage field
- Charges collected by the underlying pixels
- 256x256 pixel image



Charge diffusion and collection



Timepix output



DOSE & DOSE-EQUIVALENT

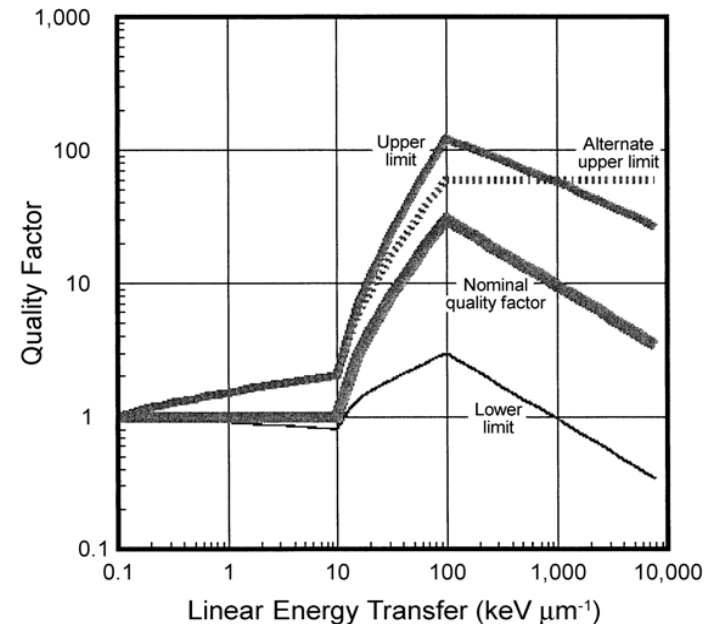
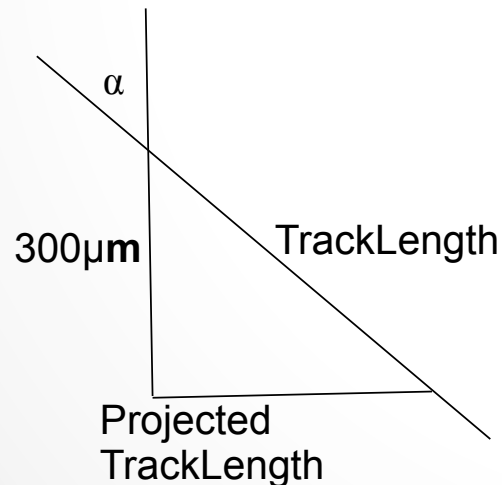
$$D_{Si} = E_{TimePix} \text{ (in KeV) } \{ 1 / [0.14 \text{ g} \times 6.24 \times 10^{12} \text{ KeV/Gy g}] \}$$

$$= E_{TimePix} \text{ (in KeV) } \{ 1.153 \times 10^{-12} \} \text{ Gy}$$

$$H = Q(LET) \cdot D_{Si} \text{ (Sv)}$$

$$LET = E_{TimePix} \{ 1 / \text{TrackLength} \}$$

$$\text{TrackLength} = 300 \{ 1 / \cos(\alpha) \}$$



Quality factor as a function of LET

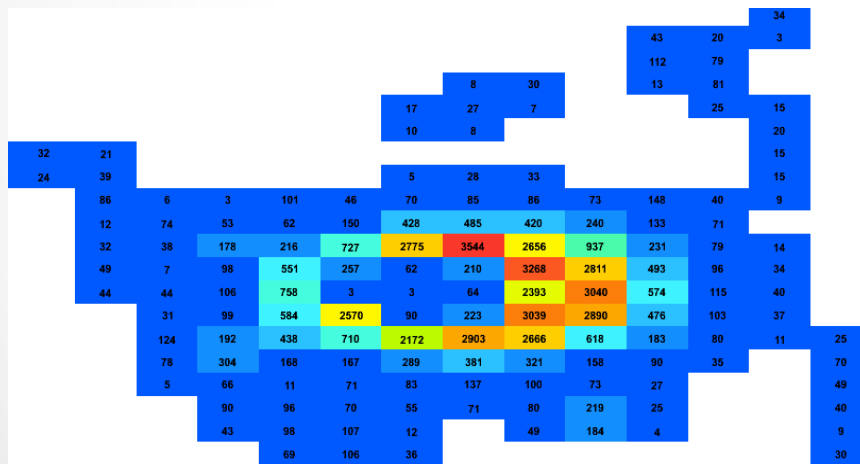


ANGLE CALCULATION

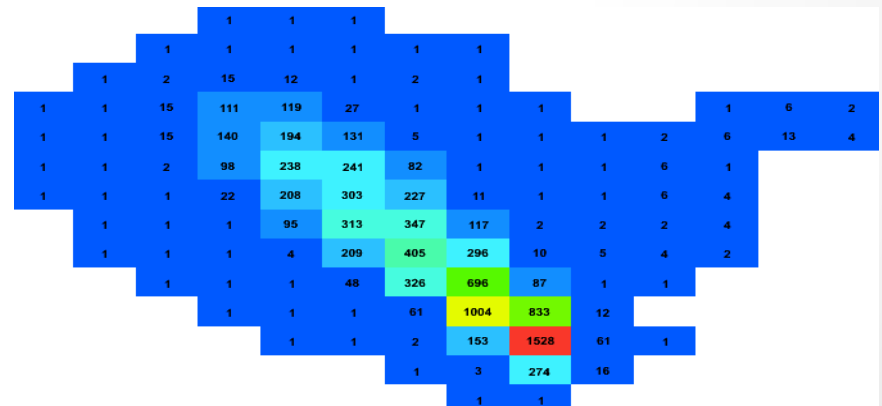
- Facilitate LET, Dose-Equivalent calculation
- Provide an important feature for ion identification
- Challenges
 - Cluster rotation
 - Delta-ray existence
 - Plasma effects
 - Bias-voltage variation
 - Cluster variation (depends on types of Ion and velocity)

CHALLENGES

- Cluster rotation
- Delta-ray existence
- Plasma effect



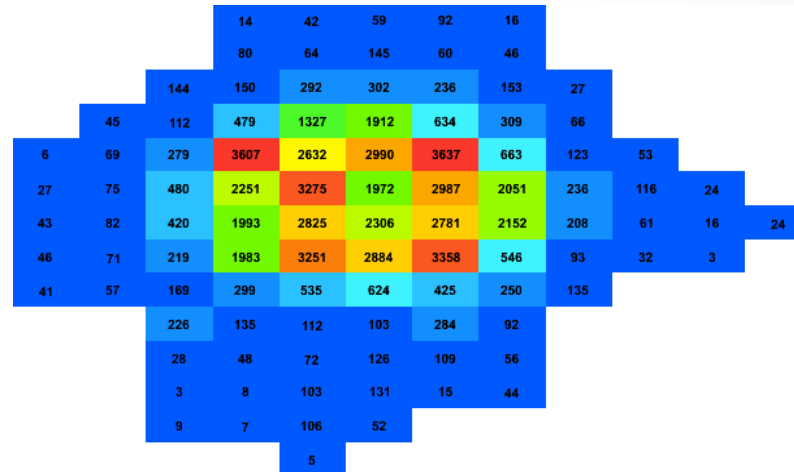
Fe-400MeV-30degree with delta-ray and plasma effect



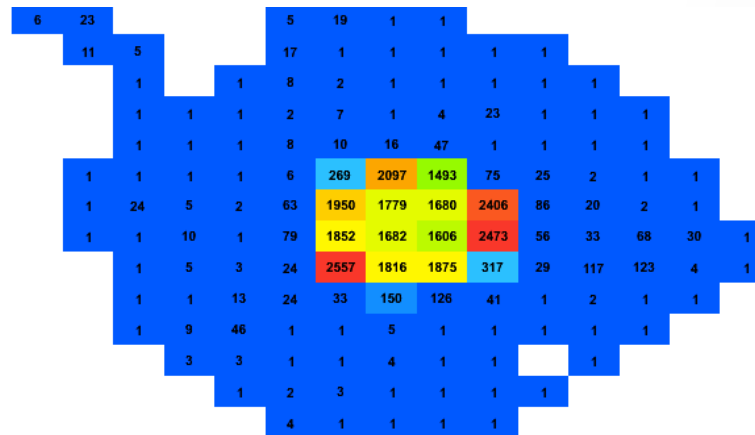
C-230MeV-60degree with azimuthal -60

BIAS-VOLTAGE VARIATION

Fe-400MeV-15V

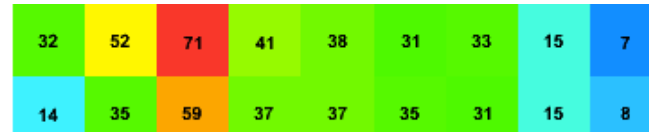


Fe-400MeV-100V



CLUSTER VARIATION

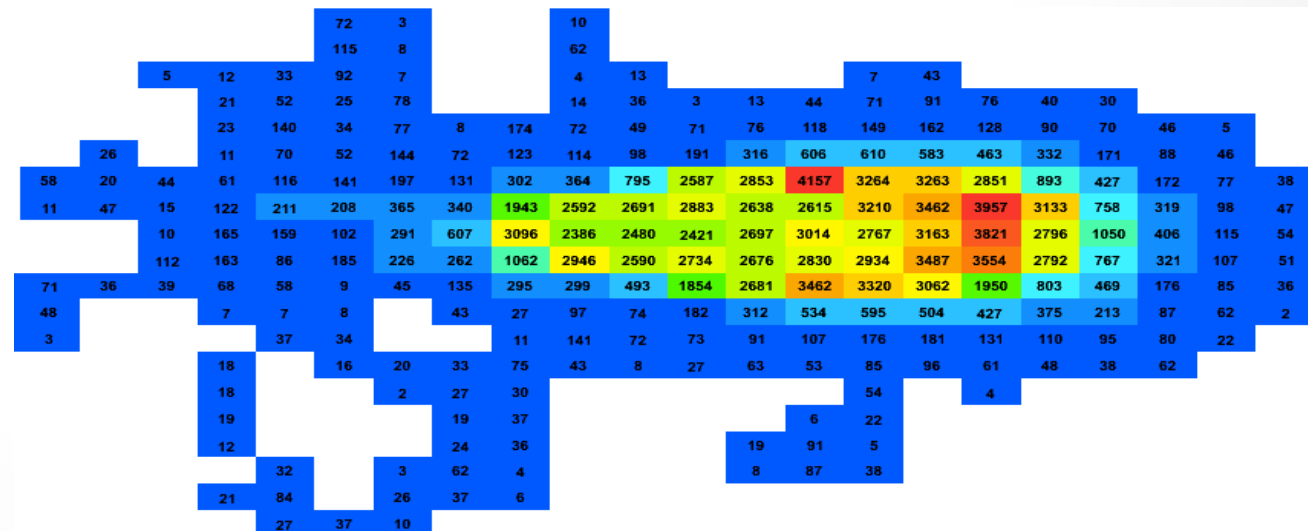
H-100MeV-
15V-60degree



C-400MeV-
15V-60degree



Fe-400MeV-
15V-60degree



AZIMUTHAL ANGLE

$$\beta_0 = \frac{\sum e_j x_j \cdot \sum x_i y_i e_i - \sum x_i^2 e_i \cdot \sum e_j y_j}{\sum e_j x_j \cdot \sum e_i x_i - \sum x_i^2 e_i \cdot \sum e_j}$$

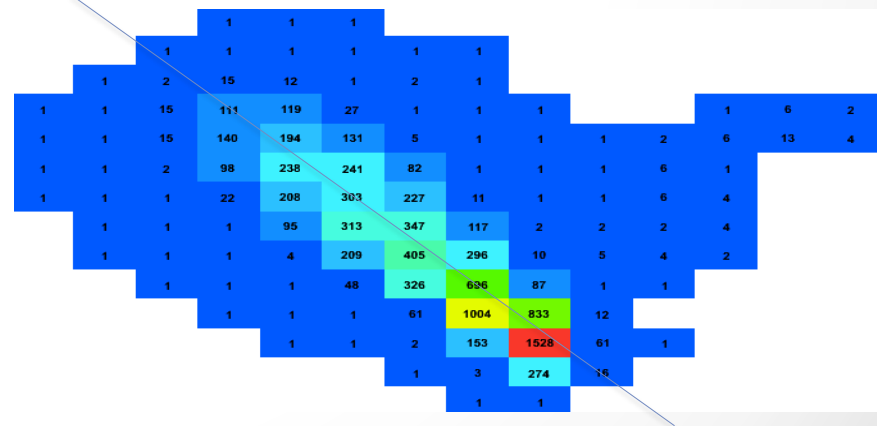
$$\beta_1 = \frac{\sum e_j y_j \cdot \sum x_i e_i - \sum x_i y_i e_i \cdot \sum e_j}{\sum e_j x_j \cdot \sum e_i x_i - \sum x_i^2 e_i \cdot \sum e_j}$$

$$y = \beta_0 + \beta_1 x$$

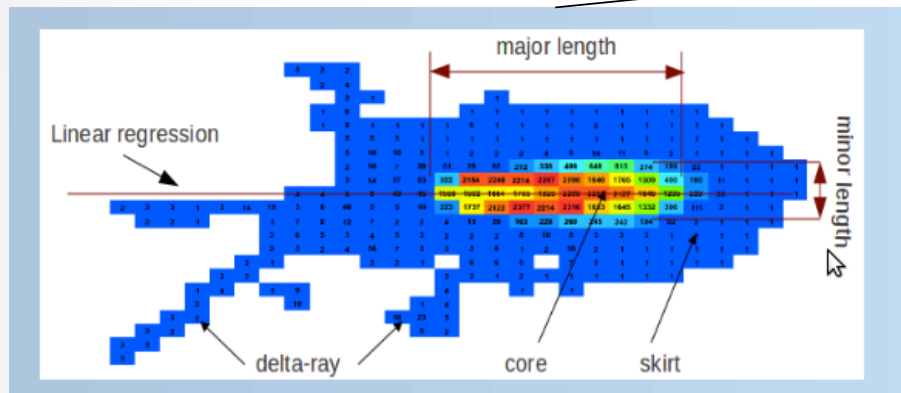
$$a = -\text{atan}(m)$$

$$X = \cos(a) * x - \sin(a) * y$$

$$Y = \sin(a) * x + \cos(a) * y$$

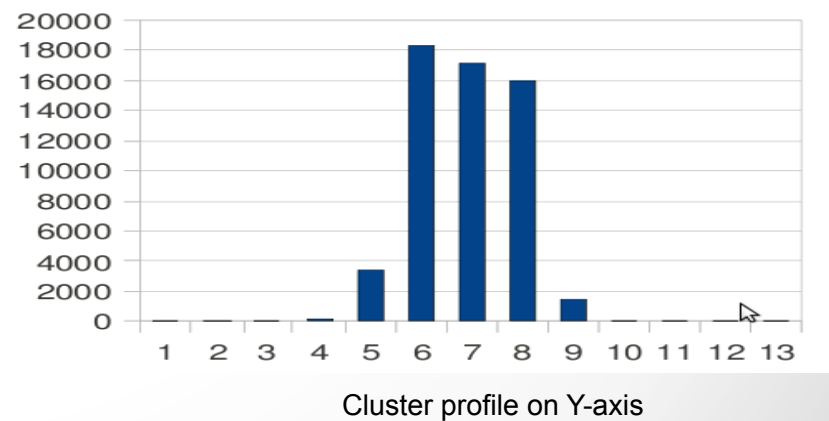
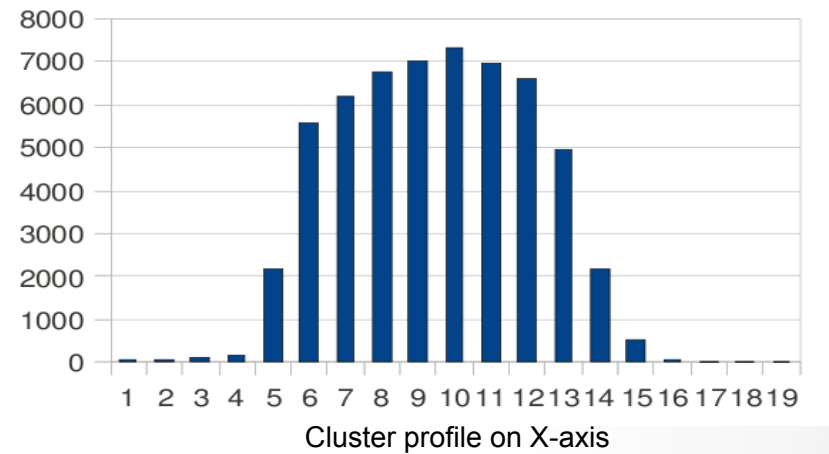


POLAR ANGLE

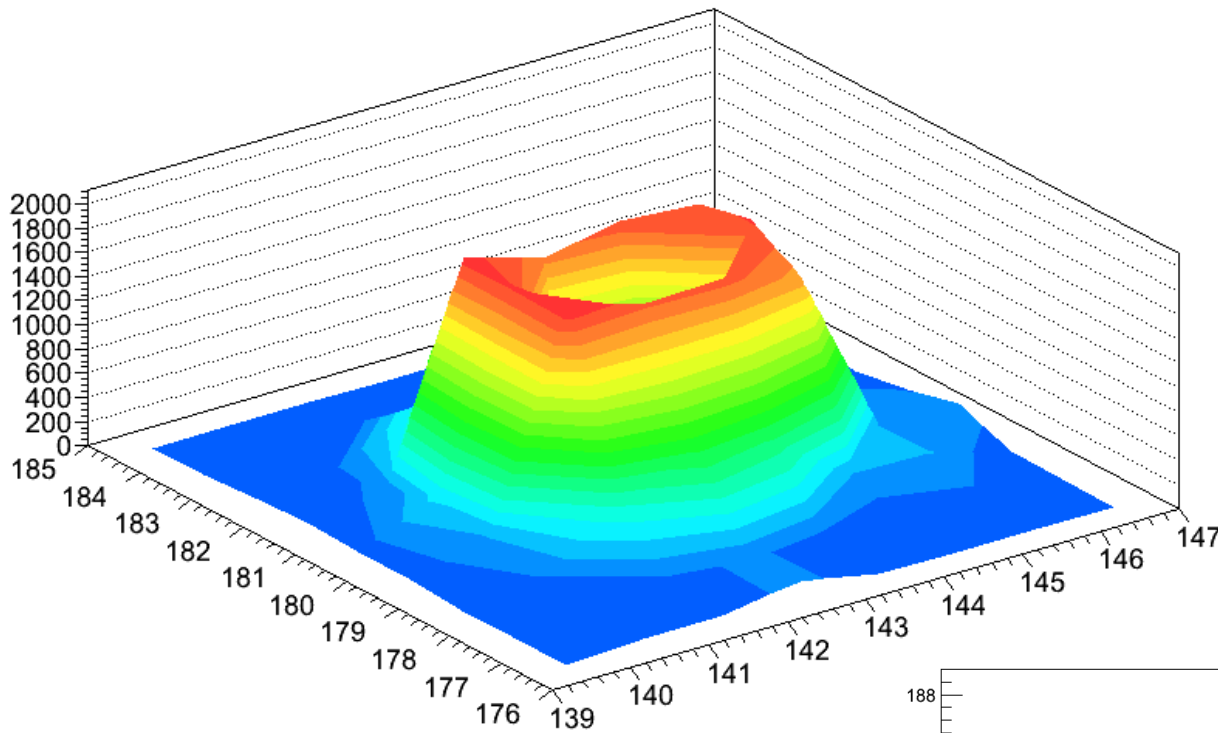


$$\tan \alpha = \frac{55}{300} \left(M - \frac{N}{2M - N} N \right) \quad \begin{matrix} M = \text{major length} \\ N = \text{minor length} \end{matrix}$$

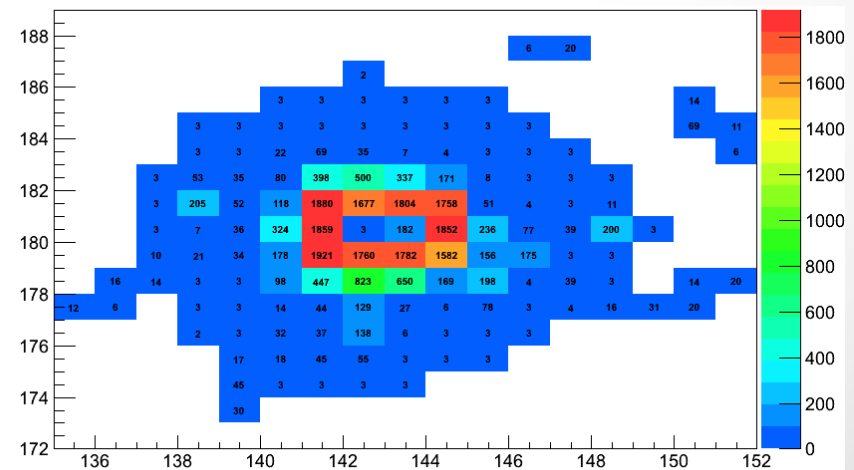
$$LET = \frac{E \cos \alpha}{300}$$



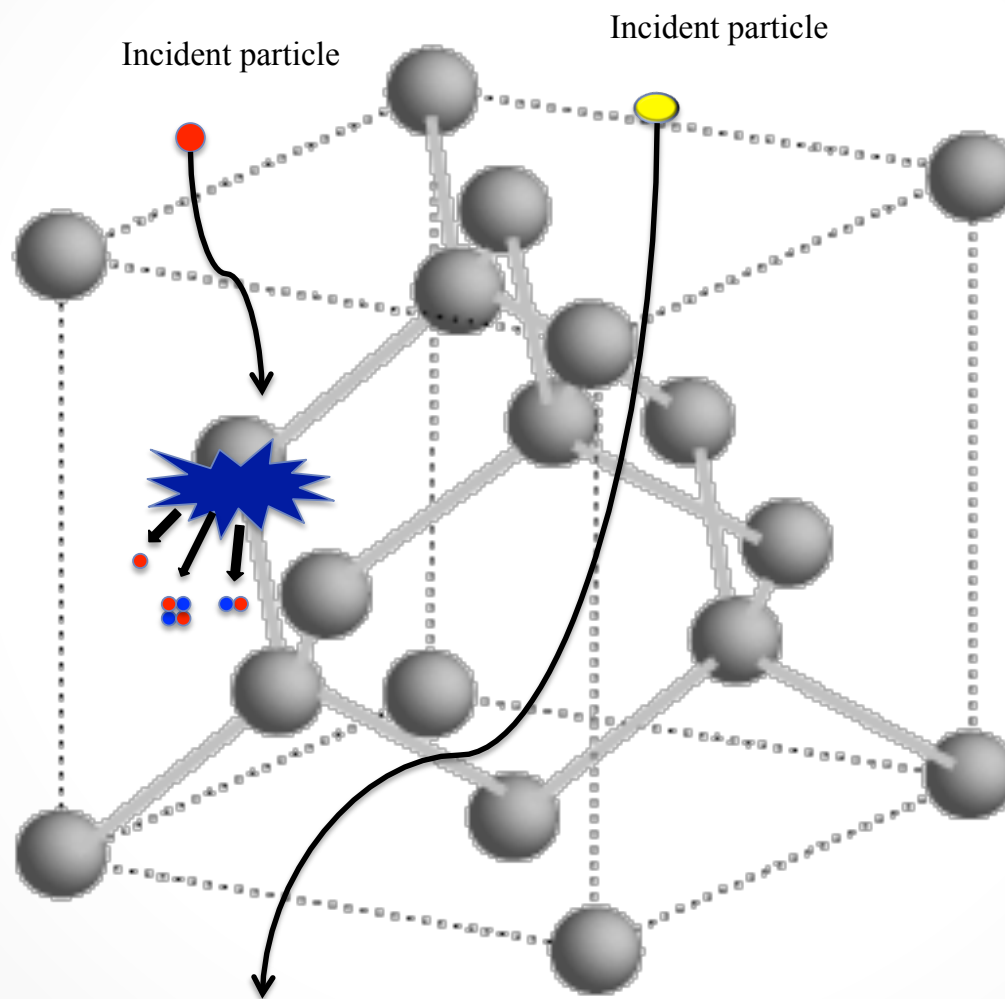
VOLCANO EFFECT



Fe-400MeV-0degree

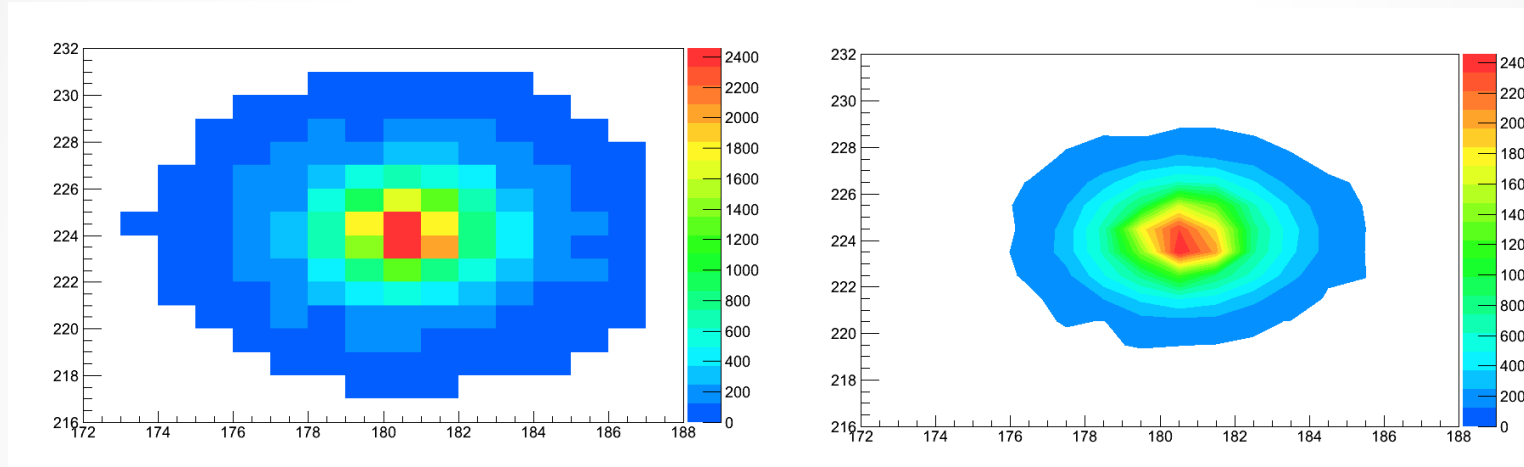


NUCLEI INTERACTION

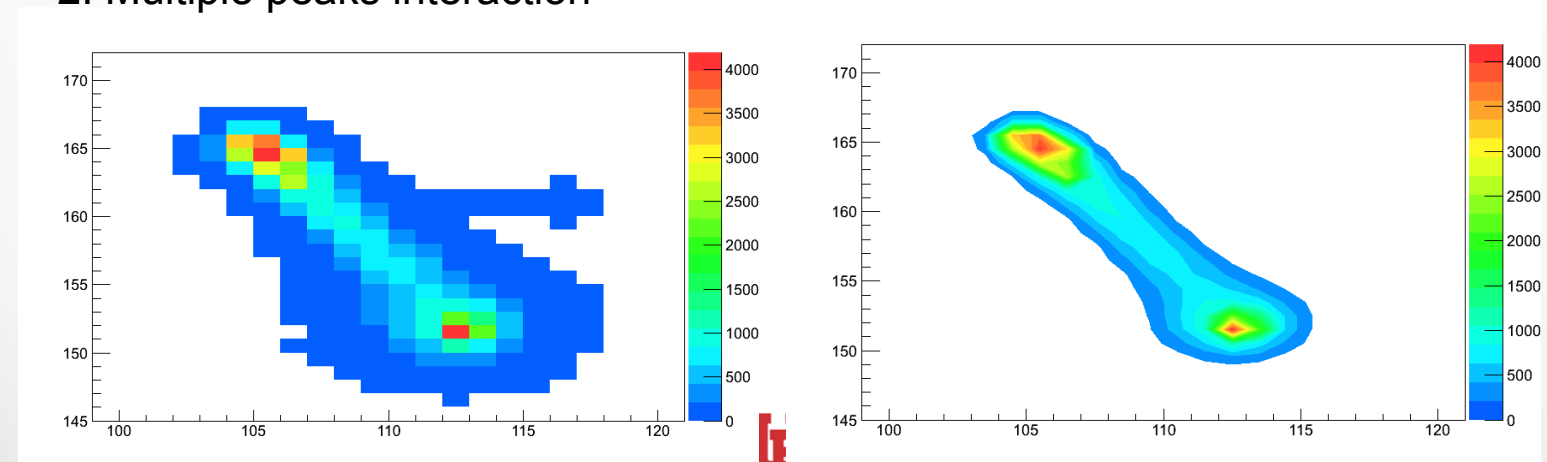


INTERACTIONS

1. Vertical interaction

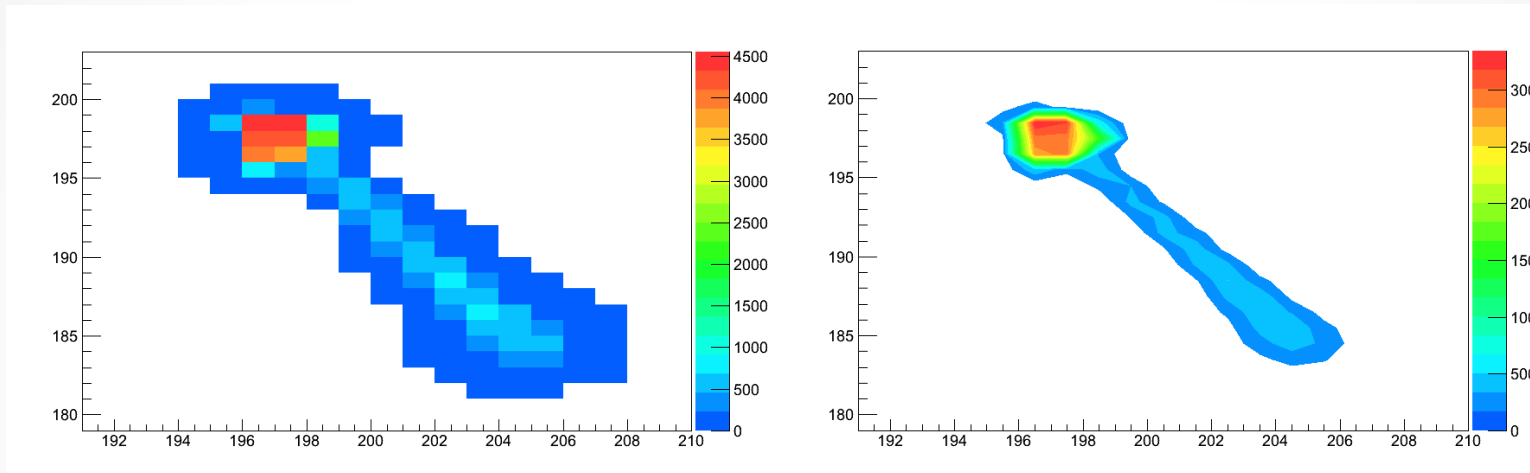


2. Multiple peaks interaction

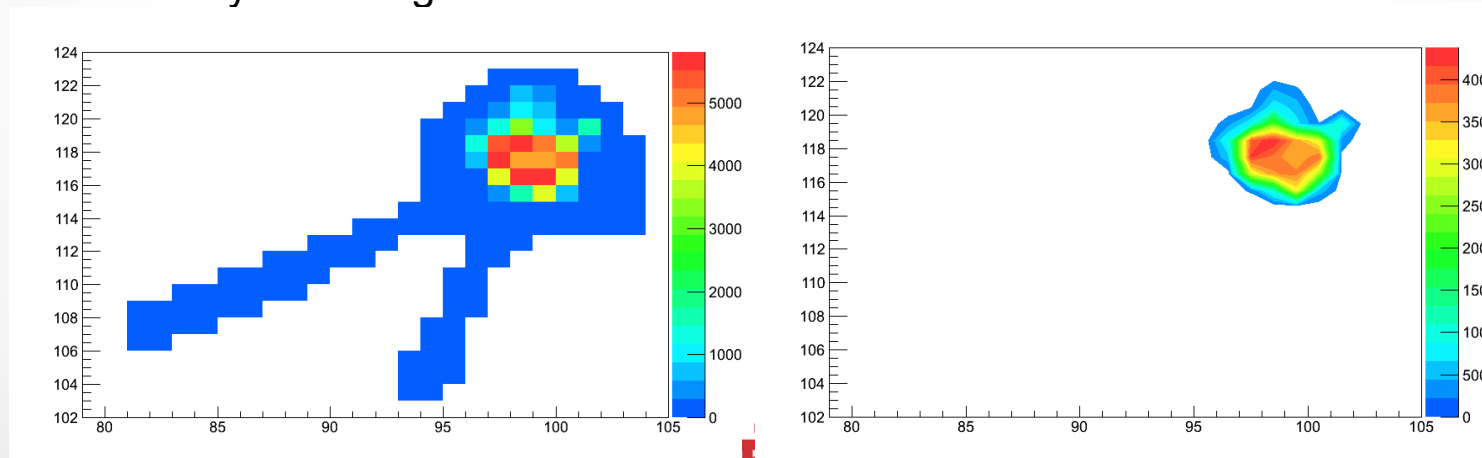


INTERACTIONS

3. Visible fragments interaction



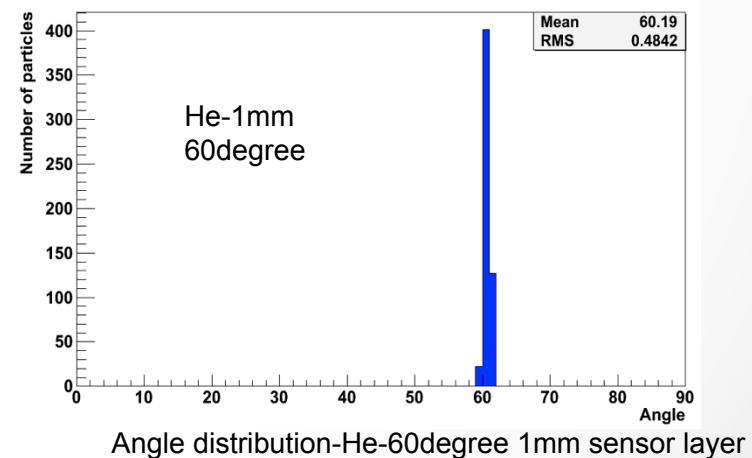
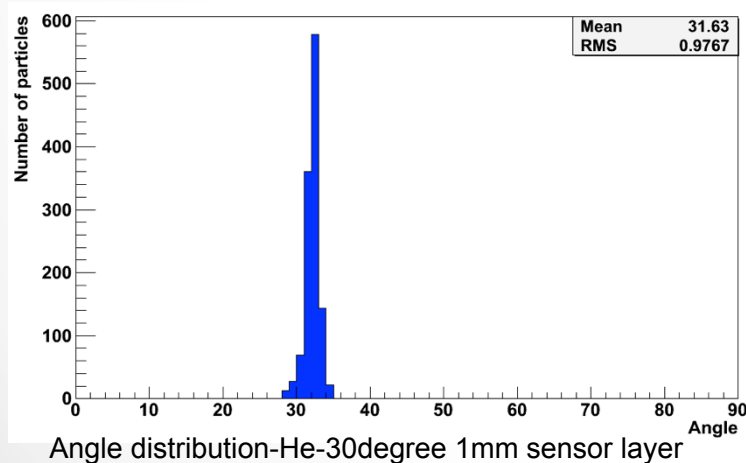
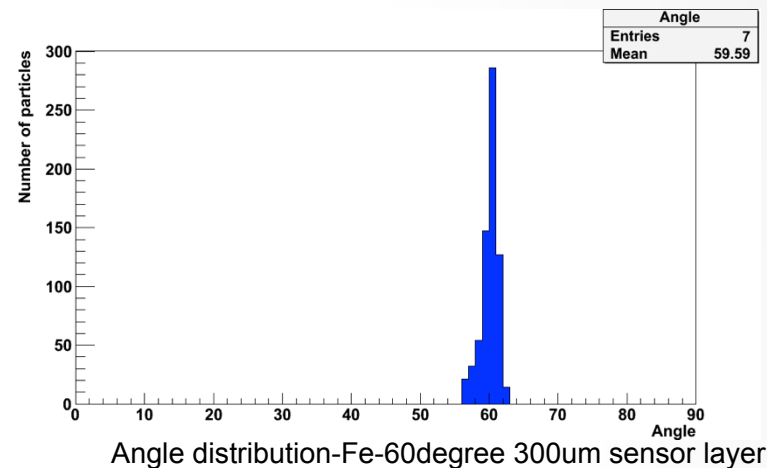
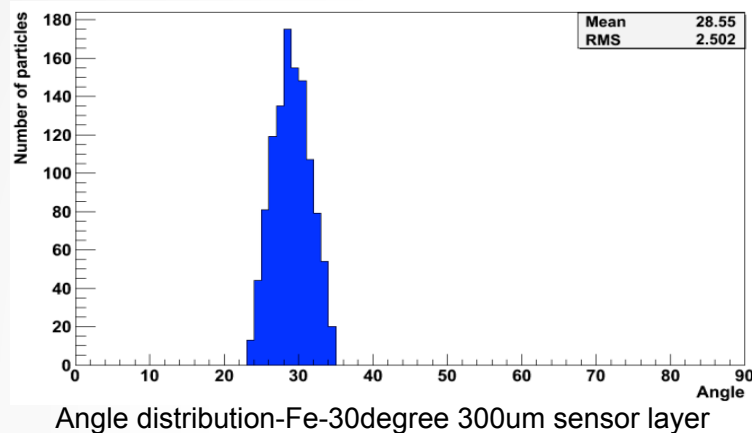
4. Delta-rays-like fragments interaction



EXPERIMENTAL RESULTS

- Angle and LET
- HIMAC & NSRL Data
 - ◆ H-100MeV, He-100MeV, C-300MeV, N-290MeV, O-430MeV, Si-400MeV, Fe-400MeV
 - ◆ 0, 30, 60, 75 degree
 - ◆ 1000 Frames
- ISS Data
- Pre-processing
 - ◆ Remove overlapping clusters
 - ◆ Ignore clusters of no interest

ANGLE DISTRIBUTION



EXPERIMENTAL RESULTS - ANGLE

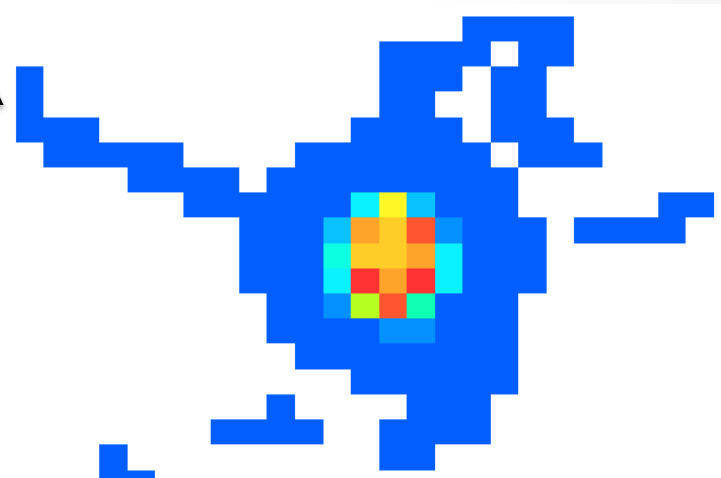
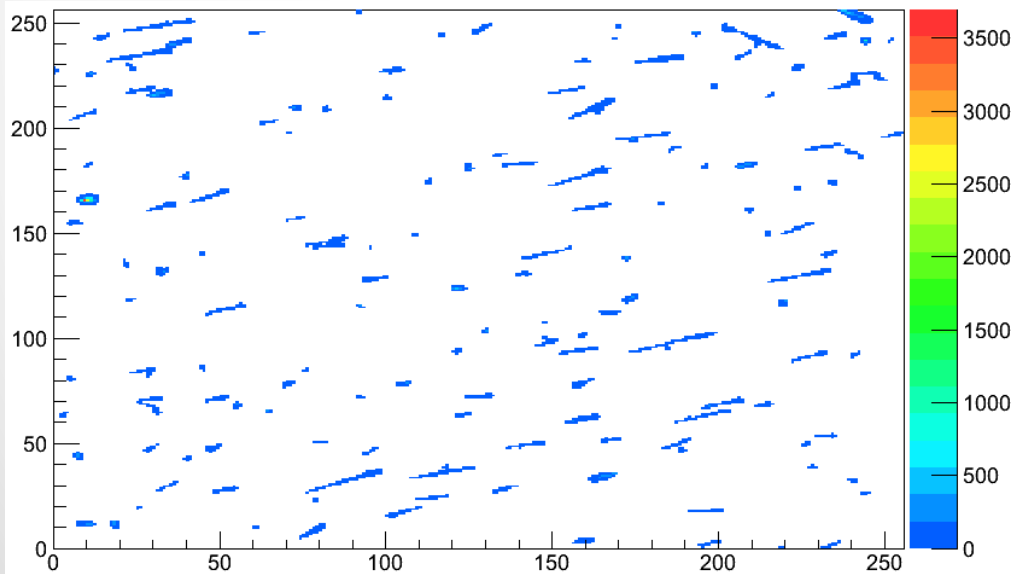
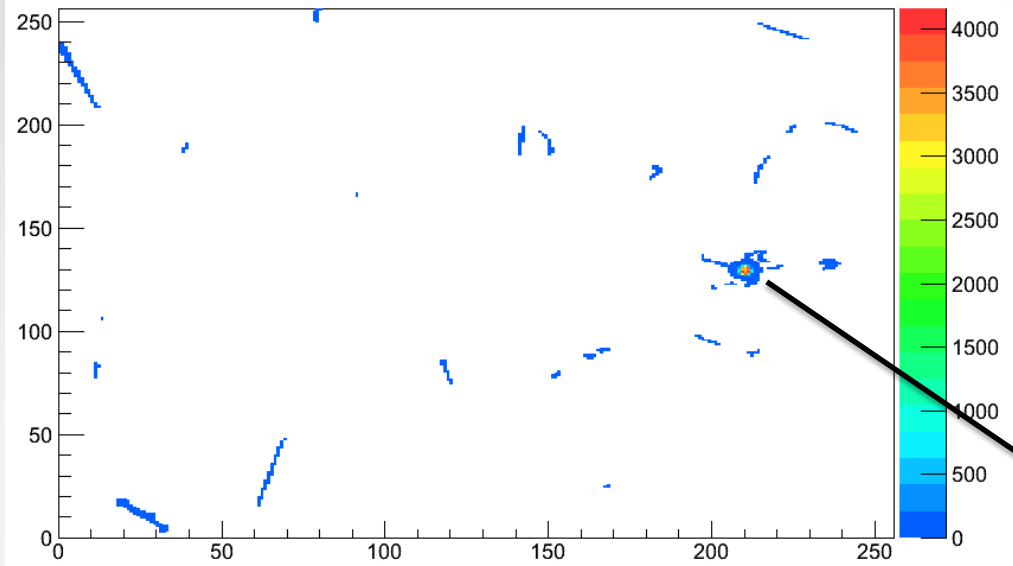
	0 degree		30 degree		60 degree		75 degree	
	Mean	RMS	Mean	RMS	Mean	RMS	Mean	RMS
H-100MeV	0.6	1.3	30.2	3.8	59.7	1.2	74.5	1.3
He-100MeV	2.1	6.8	30.2	3.7	60.1	1.3	74.7	1.5
C-300MeV			29.7	4.3	60.9	3.6		
O-430MeV	4.3	6.2	29.7	3.6	60.1	1.3	74.7	0.6
N-290MeV	4.3	6.6	29.1	3.6	60.5	1.1	75.2	0.6
Si-400MeV	2.6	3.5	25.5	4.6	59.5	1.8	73.6	1.1
Fe-400MeV	3.8	4.5	24.1	5.2	61.6	1.1	75.9	1.5

EXPERIMENTAL RESULTS - LET

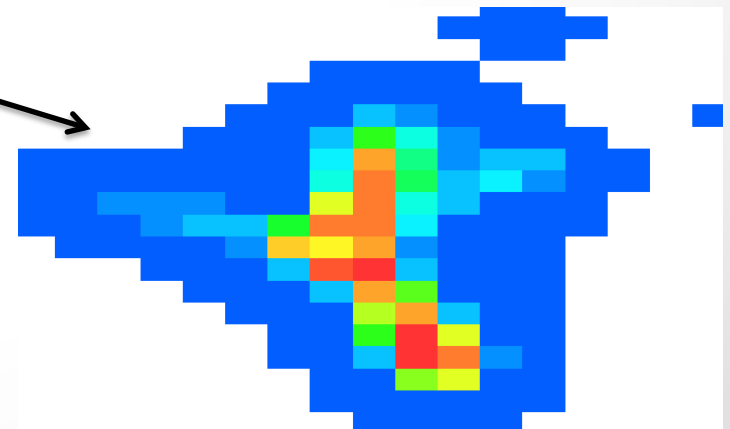
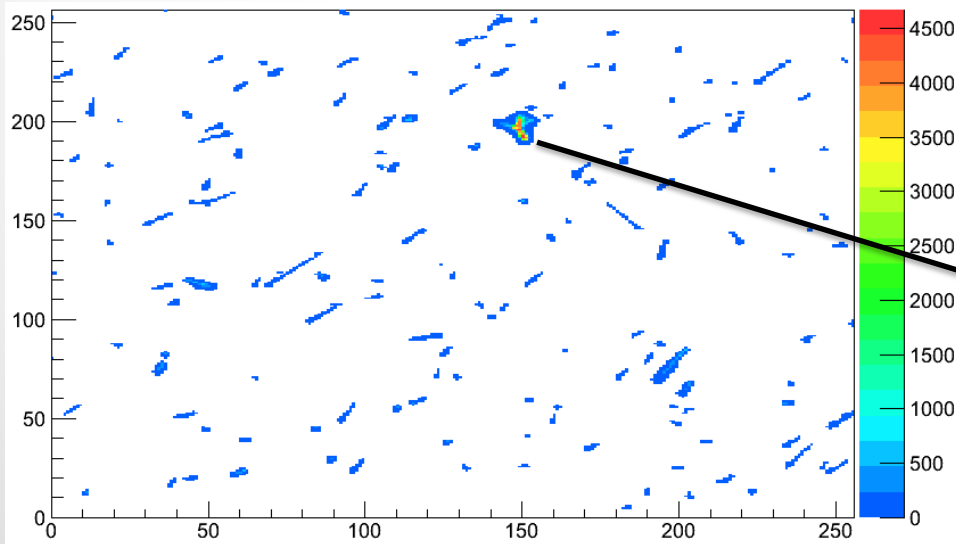
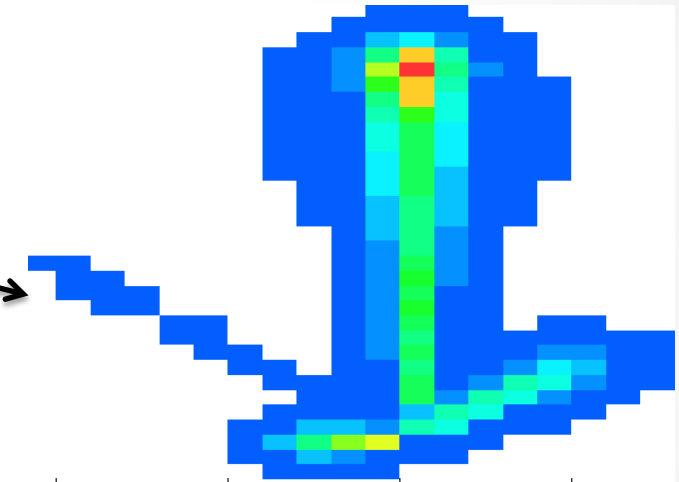
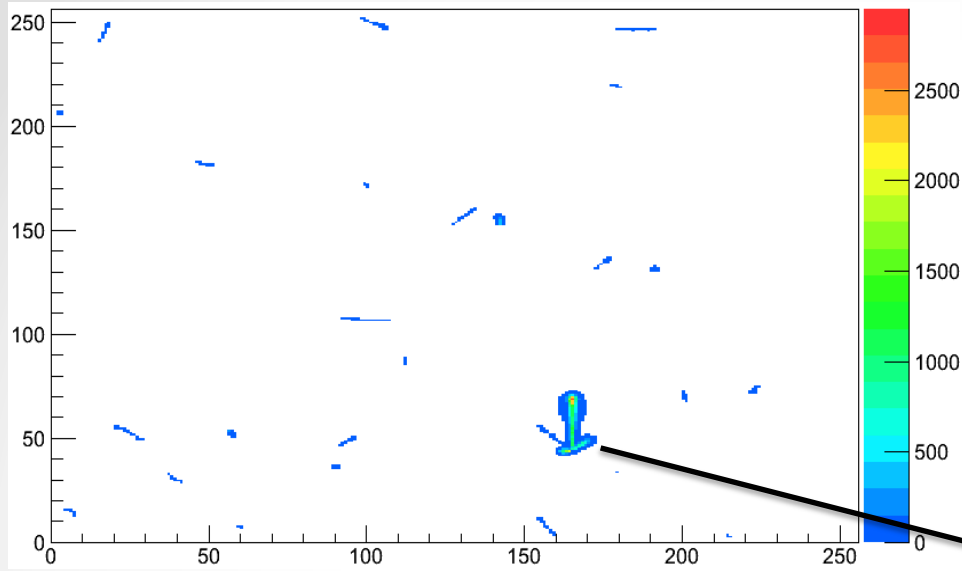
	SRIM LET	0 degree		30 degree		60 degree		75 degree	
	KeV/um	Mean	RMS	Mean	RMS	Mean	RMS	Mean	RMS
H-100MeV	1.36	1.4	0.3	1.3	0.3	1.26	0.3	1.3	0.3
He-100MeV	5.42	5.5	0.75	5.67	0.54	5.7	0.6	6.0	0.54
C-300MeV	23.0			25.4	3.6	26.6	4.1		
O-430MeV	35.0	32.2	7.7	38.8	5.4	39.6	4.8	41.0	4.4
N-290MeV	32.0	31.0	7.6	29.1	2.8	31.9	2.7	33.0	2.8
Si-400MeV	110.0	106.0	18.8	113.0	24.2	125.0	17.0	140.0	14.8
Fe-400MeV	377.0	374.0	40.4	380.0	49.0	328.0	40.5	340.0	23.8



ISS DATA

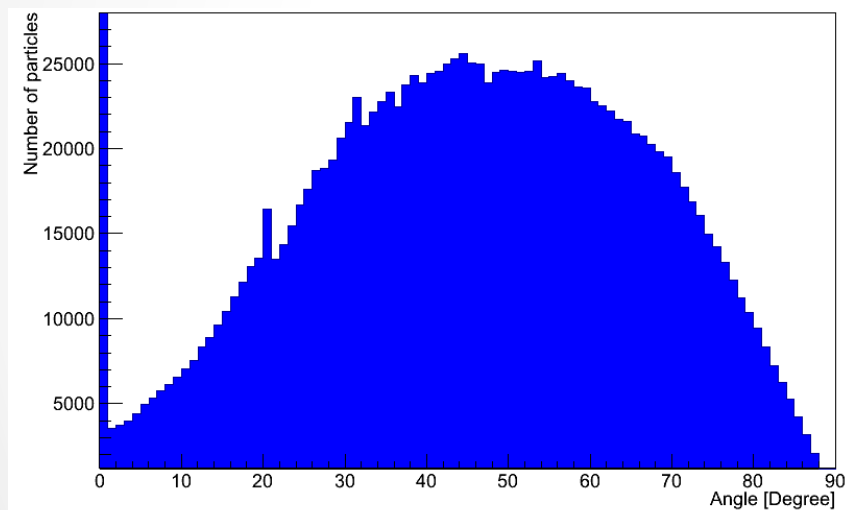


ISS DATA

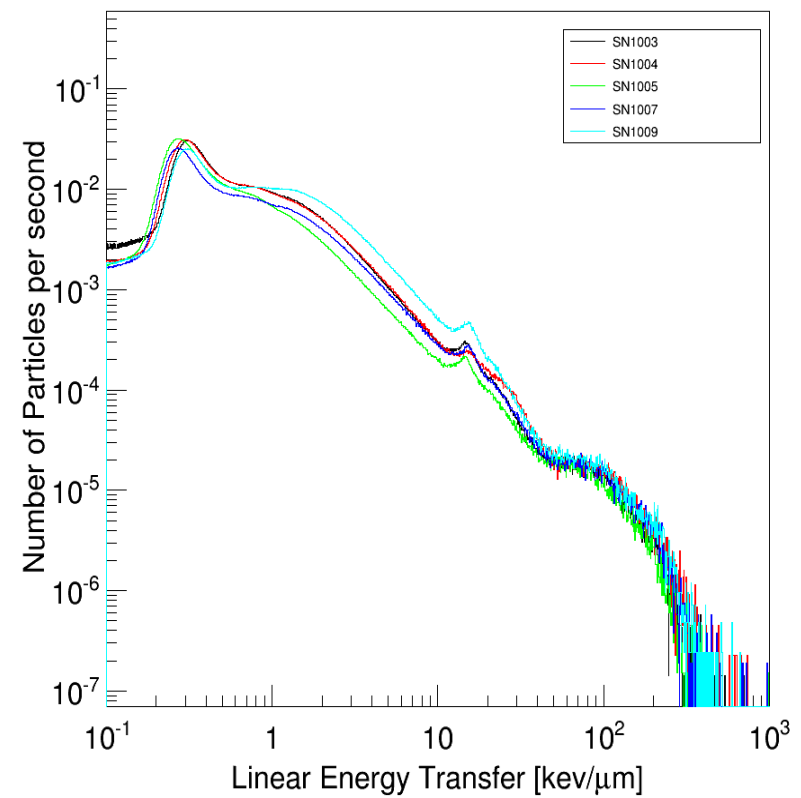


ISS DATA

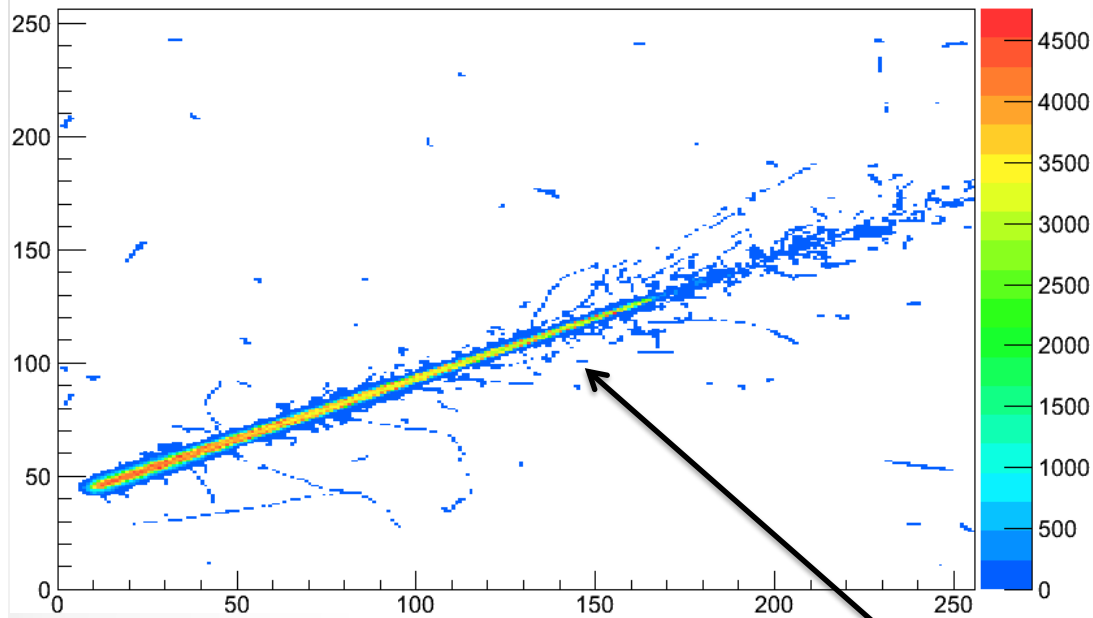
Angle distribution



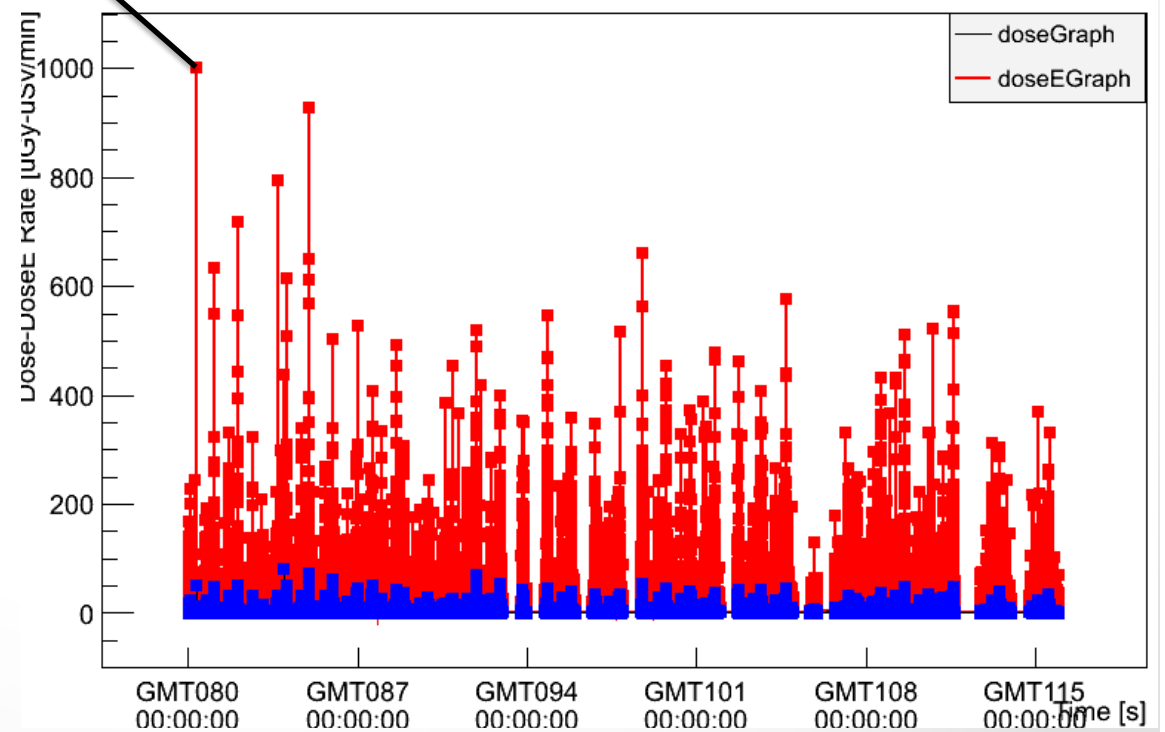
LET Distribution



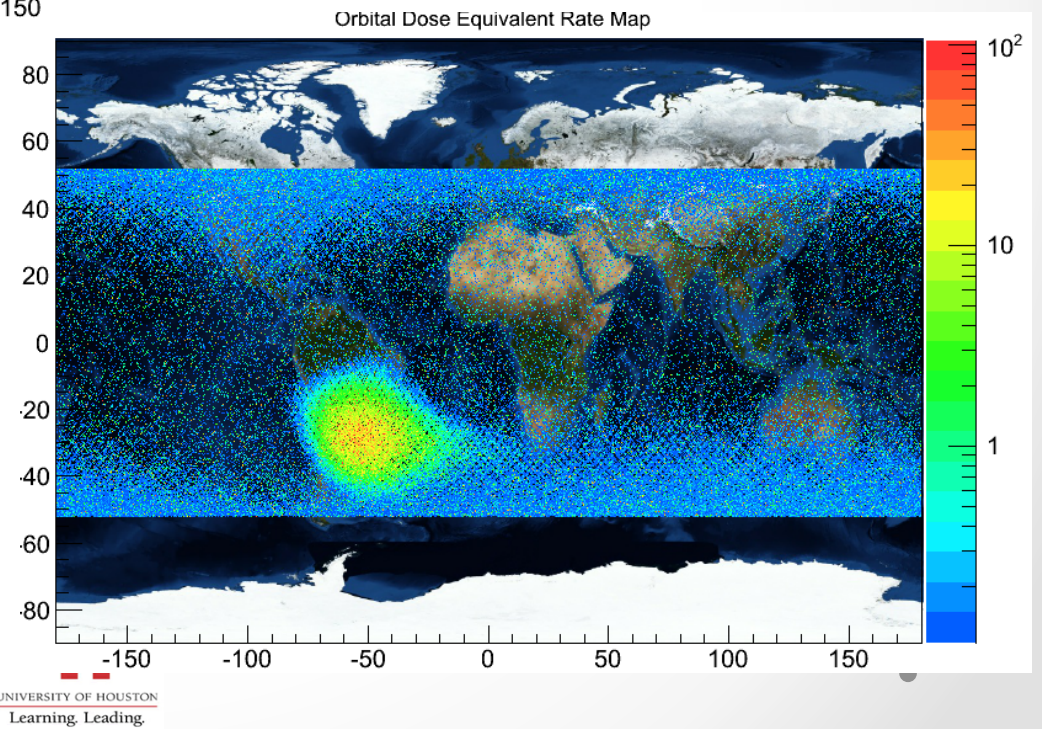
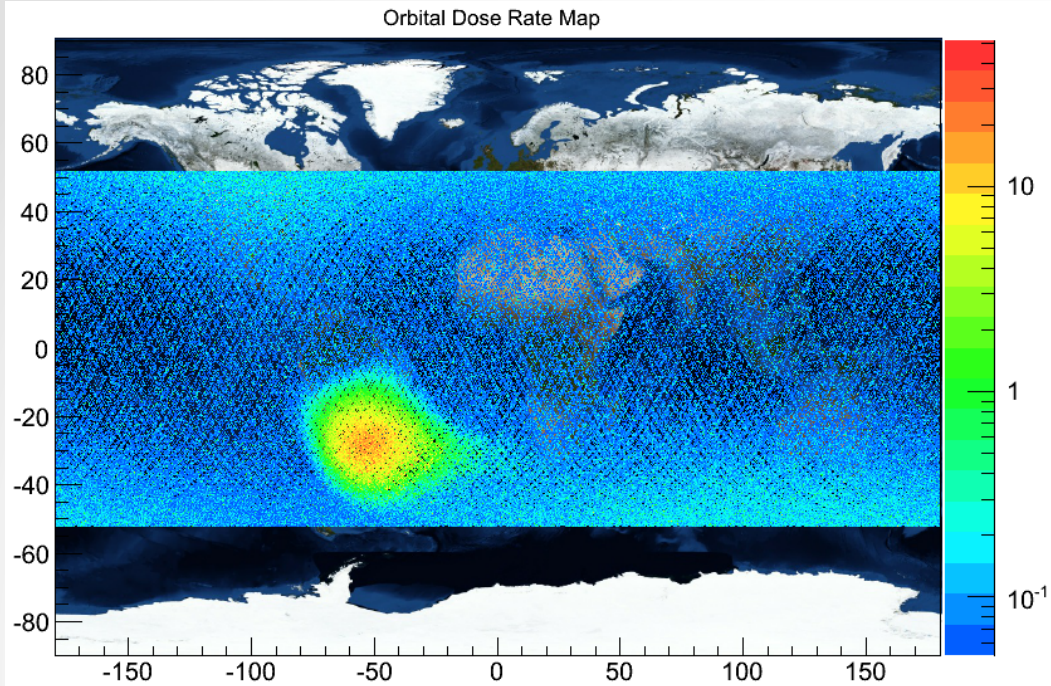
Thu Mar 21 07:46:29.084779 2013 , Acq_Time = 4.0000 [s] I04-W0094
Dose = 50.9021 [uGy/min], Dose equivalent = 1002.2537 [uSv/min], Occupancy = 3221



ISS DATA



ISS DATA



CONCLUSIONS

- Detection and visualization of primary and secondary particles.
- Angle calculation.
- LET estimation method.
- Dose-equivalent calculation.
- Plasma effect correction.
- Interactions identification.
- Development data analysis tools for processing HIMAC ISS data.

FUTURE WORK

- Improve methods of plasma effect correction and interaction identification
- Recover overlapping particles
- Explore more relevant features that facilitate discriminating types of particles.
- Do feature selection and model selection for ion classification
- Optimize algorithms for an embedded system (DSP/ARM)
- Develop a software for data analysis framework processing ISS data

PUBLICATIONS

- [1] **Hoang S.**, Pinsky L., Vilalta R. (2012), *LET Estimation for Heavy Ion Particles based on a Timepix-based Si Detector*. International Conference on Computing in High Energy and Nuclear Physics (CHEP-12), New York, USA.
- [2] Stoffle N., Pinsky L., **Hoang S.**, Idarraga J., Kroupa M., Jakubek J., Turecek D., and Pospíšil S., *Initial Results on Charge and Velocity Discrimination for Heavy Ions using Silicon Timepix Detectors*. In the 14th International Workshop on Radiation Imaging Detectors, Figueira da Foz, Coimbra, Portugal.
- [3] Pinsky L., Empl A., **Hoang S.**, Stoffle N., Jakubek, J., Vykydal Z., Turecek D., Pospisil S.; Kitamura H., Ploc O., Uchihori Y., Yasuda N., Amberboy C., Hauss J., Lee K., Semones E., Zapp N., Parker R., and Cooke D., *Preparing for the First Medipix Detectors in Space*. Proceedings of the IEEE Aerospace Conference, Big Sky, Montana, March, 2012.
- [4] Vilalta R., Kuchibhotla S., **Hoang S.**, Valerio R., Ocegueda F., and Pinsky L. (2012), *Classification of Sources of Ionizing Radiation in Space Missions: A Machine Learning Approach*. Acta Futura 5.
- [5] Vilalta R., Kuchibhotla S., Ocegueda-Hernandez F., **Hoang S.**, Pinsky L. (2011) *Machine Learning for Identification of Sources of Ionizing Radiation During Space Missions*. Workshop on AI in Space: Intelligence Beyond Planet Earth. International Joint Conference on Artificial Intelligence (IJCAI-11), Barcelona, Spain.
- [6] Stoffle N., Pinsky L., Empl A., **Hoang S.**, Pospisil S., Jakubek J., Turecek D., Vykydal Z. (2011), *Simulation of Van Allen Belt and Galactic Cosmic Ray Ionized Particle Tracks in a Si Timepix Detector*. International Cosmic Ray Conference, Beijing, China.



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